

International **IR** Rectifier

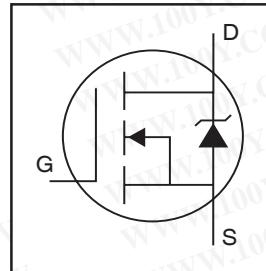
勝特力材料 886-3-5753170
胜特力电子(上海) 86-21-34970699
胜特力电子(深圳) 86-755-83298787
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PD - 94839

IRFIZ34EPbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ⑤
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free

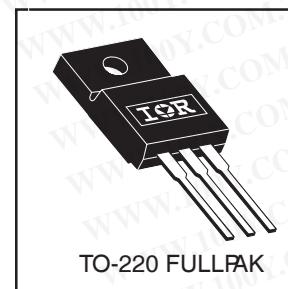


$V_{DSS} = 60V$
 $R_{DS(on)} = 0.042\Omega$
 $I_D = 21A$

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



TO-220 FULLPAK

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	21	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	15	A
I_{DM}	Pulsed Drain Current ①⑥	100	
$P_D @ T_C = 25^\circ C$	Power Dissipation	37	W
	Linear Derating Factor	0.24	W/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy ②⑥	110	mJ
I_{AR}	Avalanche Current ①⑥	16	A
E_{AR}	Repetitive Avalanche Energy ①	3.7	mJ
dv/dt	Peak Diode Recovery dv/dt ③⑥	5.0	V/ns
T_J	Operating Junction and	-55 to + 175	$^\circ C$
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf-in (1.1N•m)	

Thermal Resistance

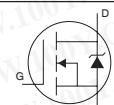
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	4.1	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient	—	65	

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	60	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.052	—	V°C	Reference to 25°C , $I_D = 1\text{mA}$ ⑥
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.042	Ω	$V_{\text{GS}} = 10\text{V}$, $I_D = 11\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	6.5	—	—	S	$V_{\text{DS}} = 25\text{V}$, $I_D = 16\text{A}$ ⑥
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{\text{DS}} = 60\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 48\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	34	nC	$I_D = 16\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	6.8		$V_{\text{DS}} = 44\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	14		$V_{\text{GS}} = 10\text{V}$, See Fig. 6 and 13 ④⑥
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	7.0	—	ns	$V_{\text{DD}} = 28\text{V}$
t_r	Rise Time	—	49	—		$I_D = 16\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	31	—		$R_G = 18\Omega$
t_f	Fall Time	—	40	—		$R_D = 1.8\Omega$, See Fig. 10 ④⑥
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	700	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	240	—		$V_{\text{DS}} = 25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	100	—		$f = 1.0\text{MHz}$, See Fig. 5⑥
C	Drain to Sink Capacitance	—	12	—		$f = 1.0\text{MHz}$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	21	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①⑥	—	—	100		
V_{SD}	Diode Forward Voltage	—	—	1.6		$T_J = 25^\circ\text{C}$, $I_S = 11\text{A}$, $V_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	57	86	ns	$T_J = 25^\circ\text{C}$, $I_F = 16\text{A}$
Q_{rr}	Reverse Recovery Charge	—	130	200	μC	$dI/dt = 100\text{A}/\mu\text{s}$ ④⑥
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② $V_{\text{DD}} = 25\text{V}$, starting $T_J = 25^\circ\text{C}$, $L = 610\mu\text{H}$, $R_G = 25\Omega$, $I_{AS} = 16\text{A}$. (See Figure 12)
- ③ $I_{SD} \leq 16\text{A}$, $di/dt \leq 420\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑤ $t=60\text{s}$, $f=60\text{Hz}$
- ⑥ Uses IRFZ34N data and test conditions

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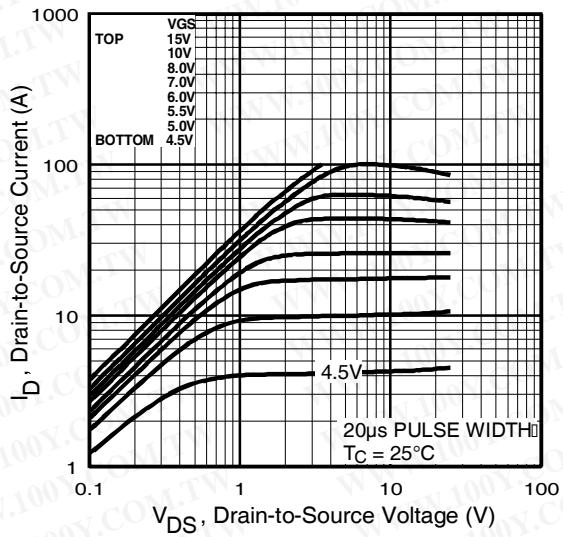


Fig 1. Typical Output Characteristics

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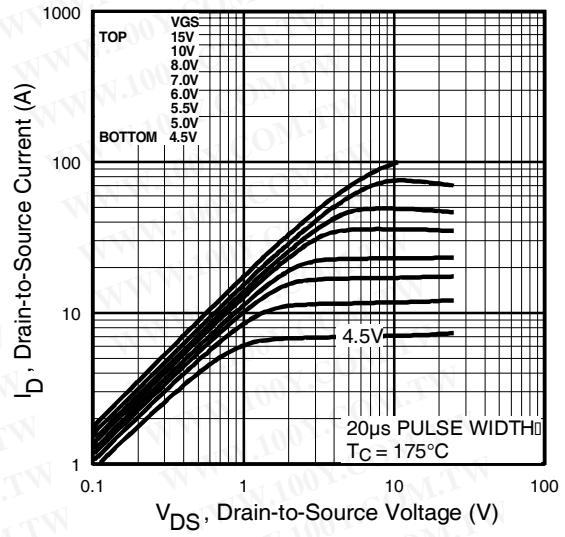


Fig 2. Typical Output Characteristics

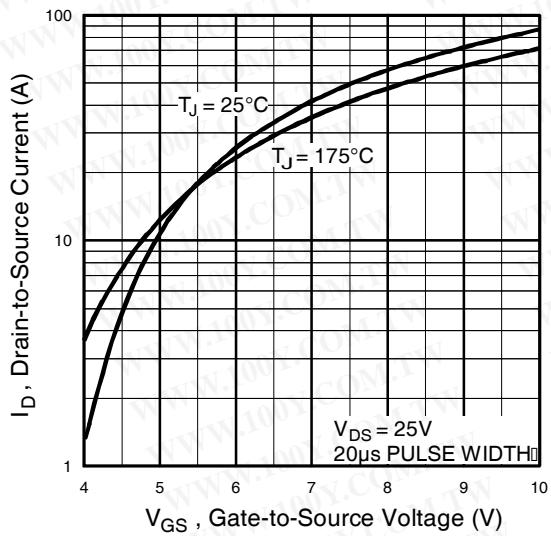


Fig 3. Typical Transfer Characteristics

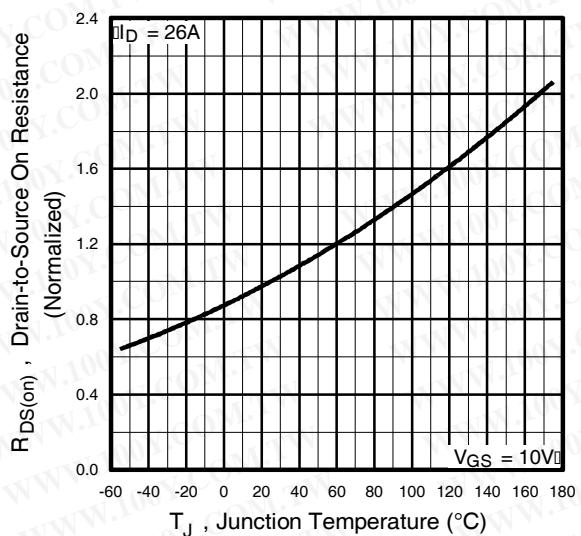


Fig 4. Normalized On-Resistance
Vs. Temperature

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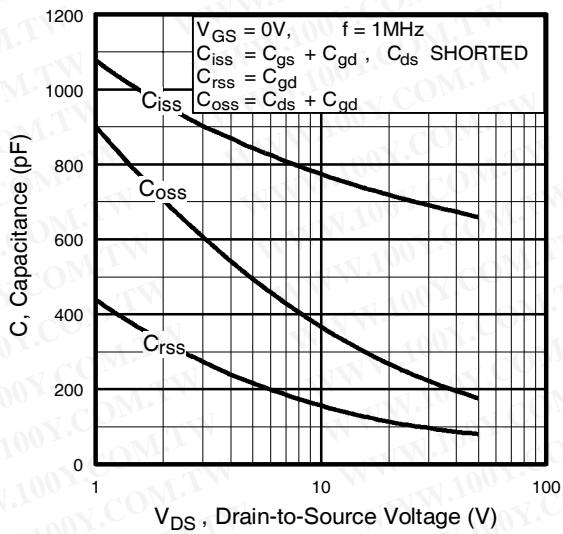


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

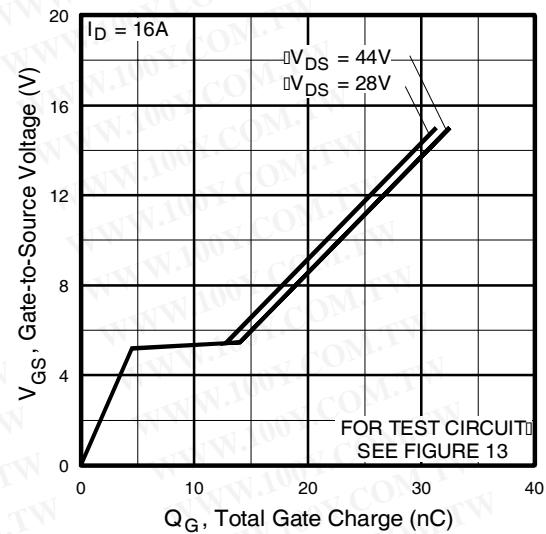


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

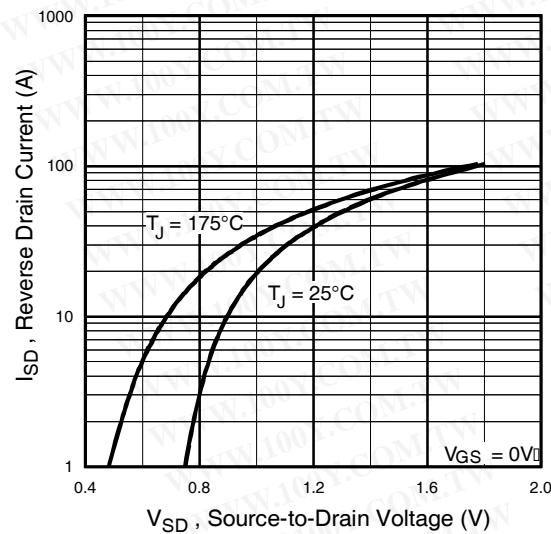


Fig 7. Typical Source-Drain Diode
Forward Voltage

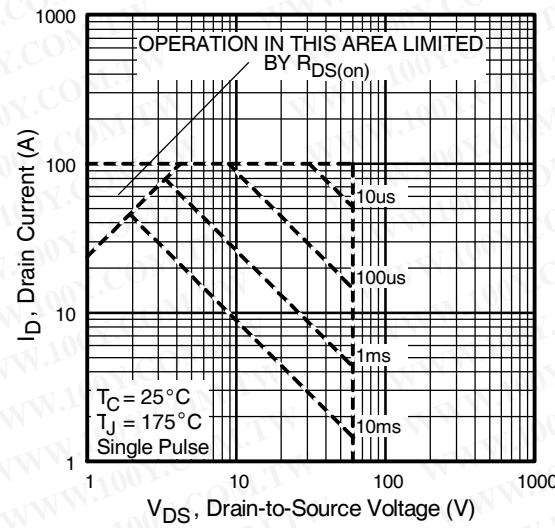


Fig 8. Maximum Safe Operating Area

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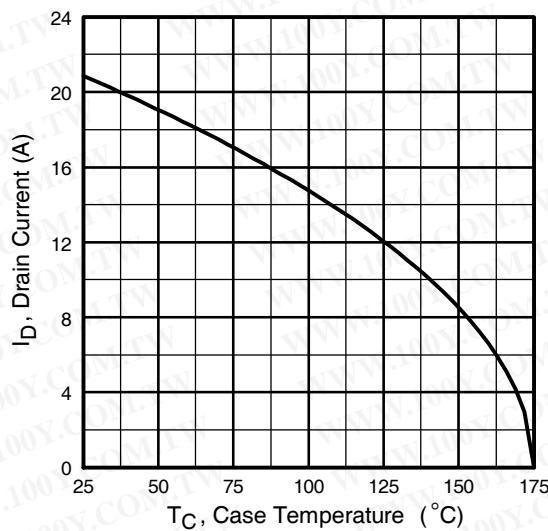


Fig 9. Maximum Drain Current Vs.
Case Temperature

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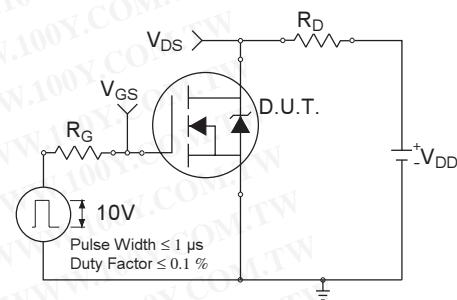


Fig 10a. Switching Time Test Circuit

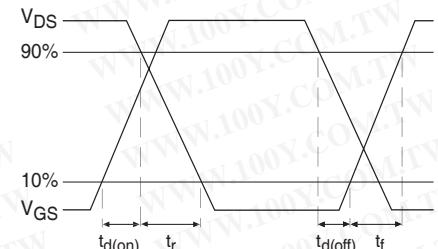


Fig 10b. Switching Time Waveforms

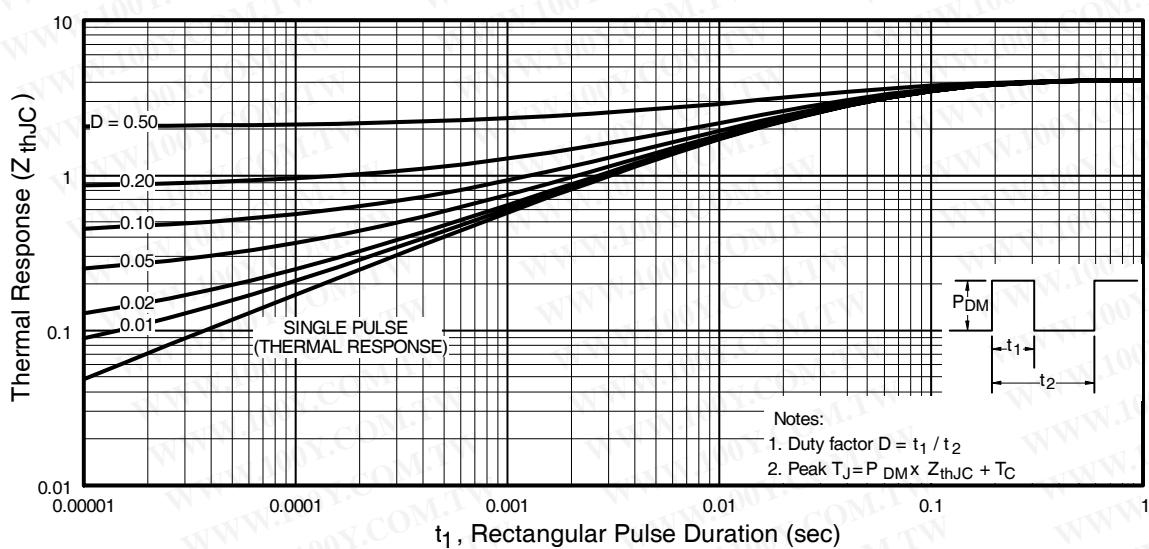


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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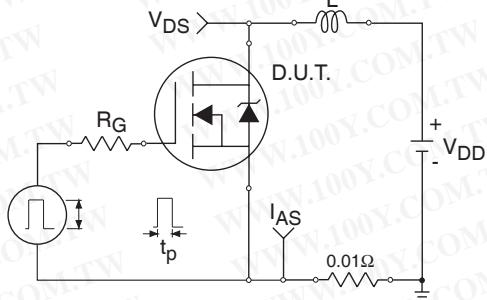


Fig 12a. Unclamped Inductive Test Circuit

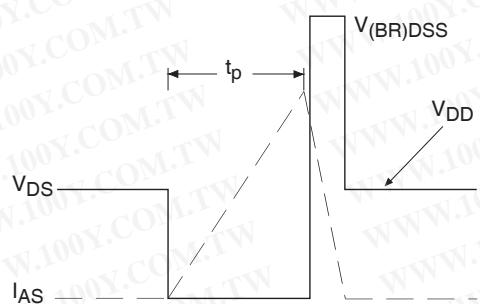


Fig 12b. Unclamped Inductive Waveforms

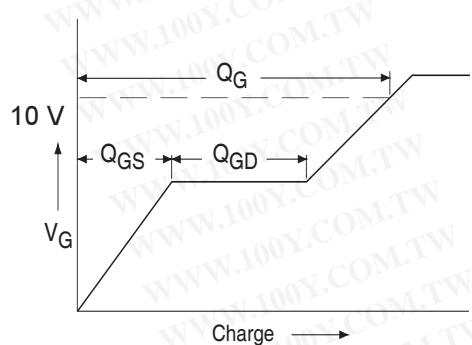


Fig 13a. Basic Gate Charge Waveform

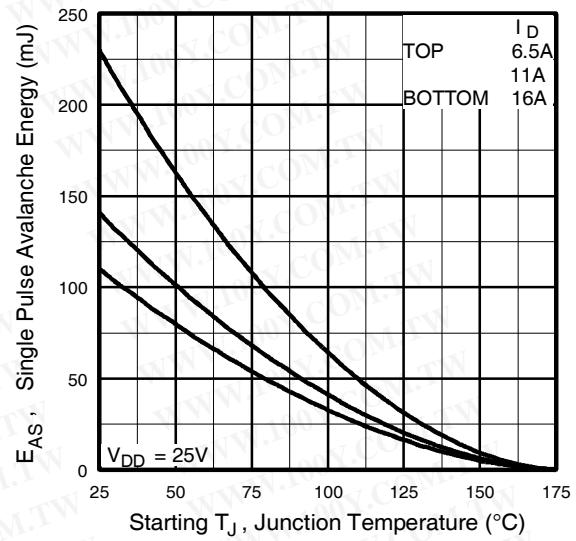


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

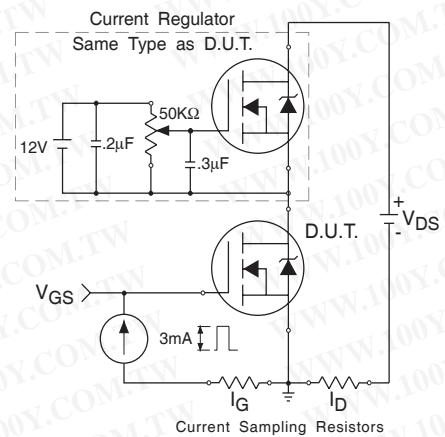
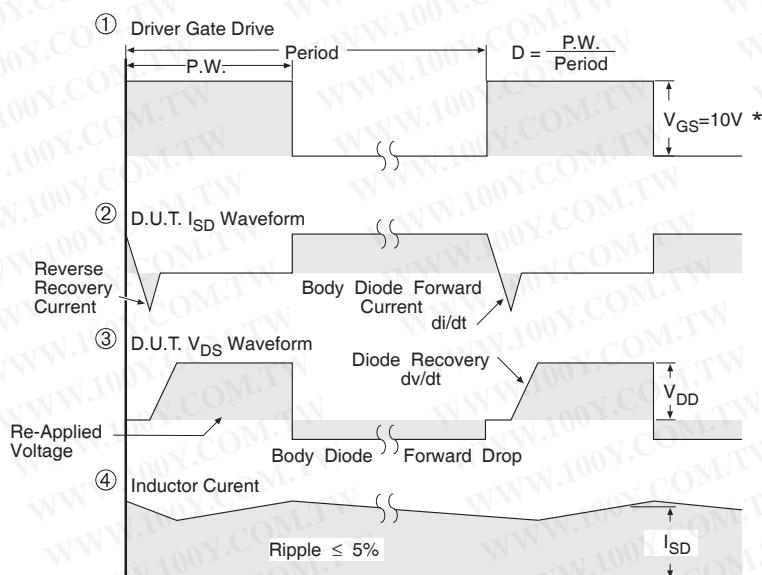
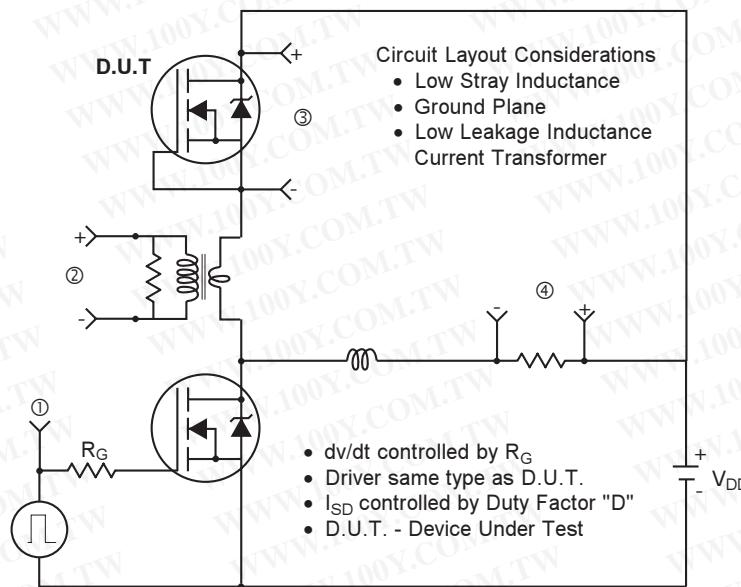


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* $V_{GS} = 5V$ for Logic Level Devices

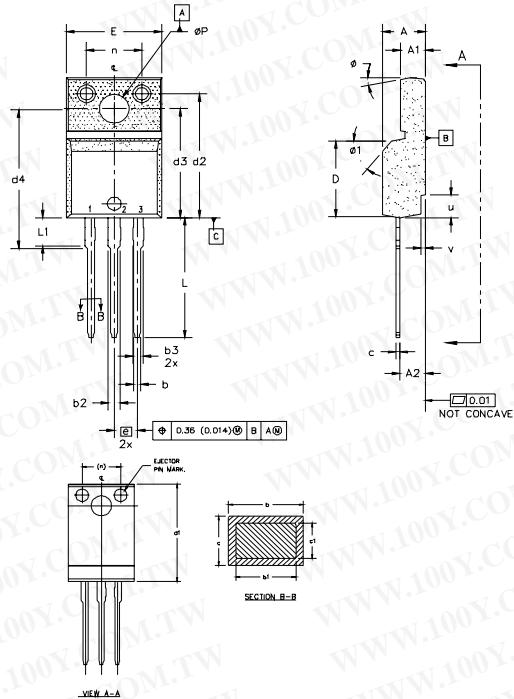
Fig 14. For N-Channel HEXFETs

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TO-220 Full-Pak Package Outline



NOTES:
 1.0 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
 2.0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
 3.0 LEAD DIMENSION AND FINISH UNCONTROLLED IN L₁.
 4.0 DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.15MM (0.006") IN TOTAL THICKNESS. ELSE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC CASE.
 △ DIMENSION b₁ APPLY TO PLASTIC BODY ONLY.
 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
 7.0 CONTROLLING DIMENSION : INCHES.

SYMBOL	DIMENSIONS			NOTES
	MILLIMETERS	INCHES	MIN. MAX.	
A	2.57	4.83	0.180	0.190
A1	2.57	2.33	0.101	0.114
A2	2.61	2.86	0.099	0.112
b	0.622	0.89	0.024	0.035
b1	0.622	0.838	0.024	0.033
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
c	0.440	0.629	0.017	0.025
c1	0.440	0.584	0.017	0.023
D	1.65	9.80	0.341	0.356
d1	16.80	16.12	0.622	0.635
d2	13.97	14.22	0.550	0.560
d3	12.30	12.92	0.484	0.509
d4	8.64	9.91	0.340	0.390
E	10.36	10.63	0.408	0.419
e	2.54 BSC		0.100 BSC	4
L	13.20	13.73	0.520	0.541
L1	3.17	3.50	0.100	0.130
n	6.05	6.15	0.238	0.242
dp	3.05	3.45	0.120	0.136
u	2.40	2.50	0.094	0.098
v	0.40	0.50	0.016	0.020
w	3"	7"	3"	7"
x	45°		45°	

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

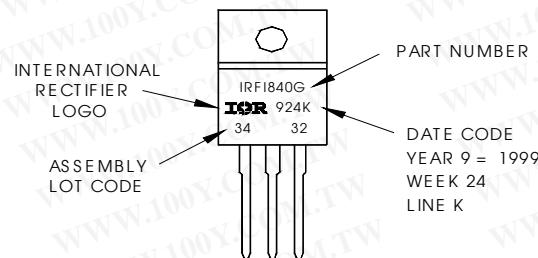
ICR1840COPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter

TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRF1840G
 WITH ASSEMBLY
 LOT CODE 3432
 ASSEMBLED ON WW 24 1999
 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line
 position indicates "Lead-Free"



Data and specifications subject to change without notice.

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IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
 TAC Fax: (310) 252-7903

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